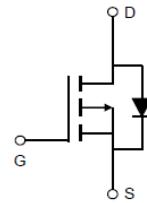
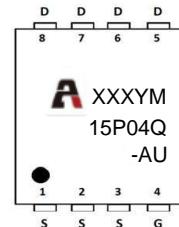


Feature

- -40V,-15A
- $R_{DS(ON)} < 33m\Omega @ V_{GS} = -10V$ TYP:27 mΩ
- $R_{DS(ON)} < 42m\Omega @ V_{GS} = -4.5V$ TYP:34 mΩ
- Advanced Trench Technology
- Lead free product is acquired
- Excellent $R_{DS(ON)}$ and Low Gate Charge
- $T_{jmax}=175^{\circ}\text{C}$
- AEC-Q101 qualified



Schematic Diagram



Marking and pin Assignment

Application

- PWM applications
- Load Switch
- Power management

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity (PCS)
15P04Q-AU	AP15P04Q-AU	PDFN3X3	13 inch	-	5000

ABSOLUTE MAXIMUM RATINGS ($T_j=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	-40	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ($T_c = 25^{\circ}\text{C}$)	I_D	-15	A
Continuous Drain Current ($T_c = 100^{\circ}\text{C}$)	I_D	-10.5	A
Pulsed Drain Current ⁽¹⁾	I_{DM}	-60	A
Single Pulsed Avalanche Energy ⁽²⁾	E_{AS}	42	mJ
Power Dissipation	P_D	38	W
Thermal Resistance from Junction to Case	R_{eJC}	3.9	$^{\circ}\text{C}/\text{W}$
Thermal Resistance from Junction to Ambient	R_{eJA}	62	$^{\circ}\text{C}/\text{W}$
Junction Temperature	T_j	175	$^{\circ}\text{C}$
Storage Temperature	T_{STG}	-55~+175	$^{\circ}\text{C}$

MOSFET ELECTRICAL CHARACTERISTICS($T_J=25^\circ\text{C}$ unless otherwise noted)

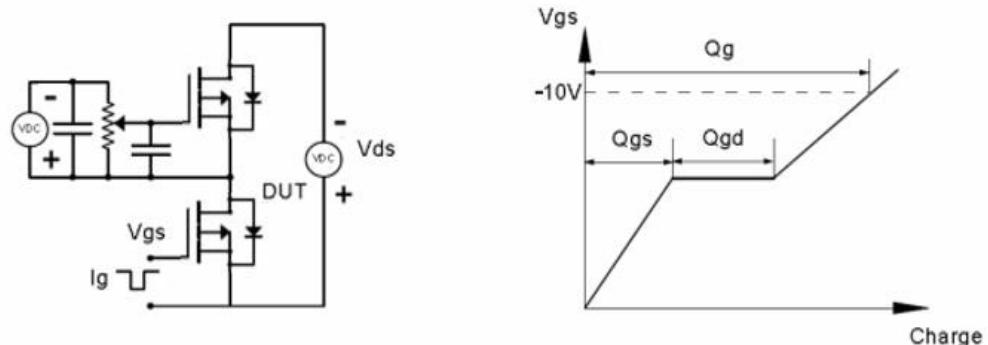
Parameter	Symbol	Test Condition	Min	Type	Max	Unit
Static Characteristics						
Drain-source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = -250\mu\text{A}$	-40	-	-	V
Zero gate voltage drain current	I_{DSS}	$V_{\text{DS}} = -40\text{V}, V_{\text{GS}} = 0\text{V}$	-	-	1	μA
Gate-body leakage current	I_{GSS}	$V_{\text{GS}} = \pm 20\text{V}, V_{\text{DS}} = 0\text{V}$	-	-	± 100	nA
Gate threshold voltage ⁽³⁾	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = -250\mu\text{A}$	-1	-1.5	-2.2	V
Drain-source on-resistance ⁽³⁾	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = -10\text{V}, I_D = -15\text{A}$	-	27	33	$\text{m}\Omega$
		$V_{\text{GS}} = -4.5\text{V}, I_D = -10\text{A}$	-	34	42	
Dynamic characteristics						
Input Capacitance	C_{iss}	$V_{\text{DS}} = -20\text{V}, V_{\text{GS}} = 0\text{V}, f = 1\text{MHz}$	-	1512	-	pF
Output Capacitance	C_{oss}		-	115	-	
Reverse Transfer Capacitance	C_{rss}		-	104	-	
Switching characteristics						
Turn-on delay time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = -20\text{V}, I_D = -15\text{A}, V_{\text{GS}} = -10\text{V}, R_G = 2.5\Omega$	-	4	-	ns
Turn-on rise time	t_r		-	27.5	-	
Turn-off delay time	$t_{\text{d}(\text{off})}$		-	39.4	-	
Turn-off fall time	t_f		-	10.4	-	
Total Gate Charge	Q_g	$V_{\text{DS}} = -20\text{V}, I_D = -8\text{A}, V_{\text{GS}} = -10\text{V}$	-	27.6	-	nC
Gate-Source Charge	Q_{gs}		-	4.4	-	
Gate-Drain Charge	Q_{gd}		-	5.4	-	
Source-Drain Diode characteristics						
Diode Forward voltage ⁽³⁾	V_{DS}	$V_{\text{GS}} = 0\text{V}, I_S = -15\text{A}$	-	-	-1.2	V
Diode Forward current ⁽⁴⁾	I_S		-	-	-15	A
Reverse Recovery Time	T_{rr}	$V_{\text{GS}} = 0\text{V}, I_S = -15\text{A}, \frac{dI}{dt} = 100\text{A}/\mu\text{s}$	-	10.9	-	ns
Reverse Recovery Char	Q_{rr}		-	2.09	-	nC

Notes:

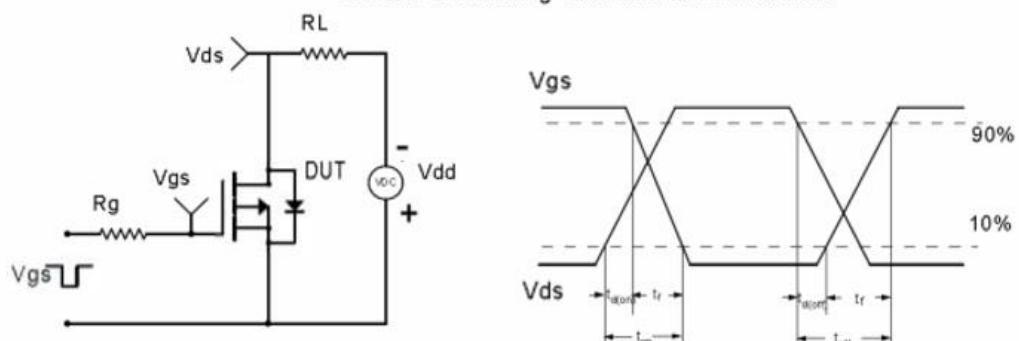
1. Repetitive Rating: pulse width limited by maximum junction temperature
2. EAS Condition: $T_J=25^\circ\text{C}, V_{\text{DD}}=-20\text{V}, R_G=25\Omega, L=0.5\text{mH}, I_{\text{AS}}=-13\text{A}$
3. Pulse Test: pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
4. Surface Mounted on FR4 Board, $t \leq 10$ sec

Test Circuit & Waveform

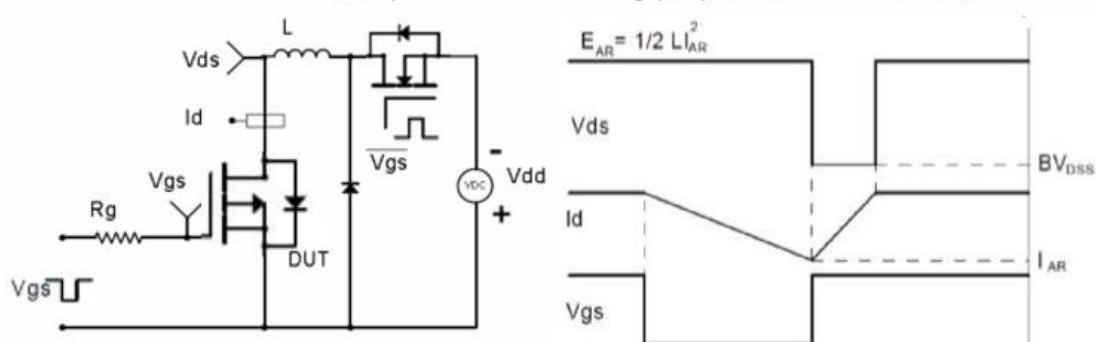
Gate Charge Test Circuit & Waveform



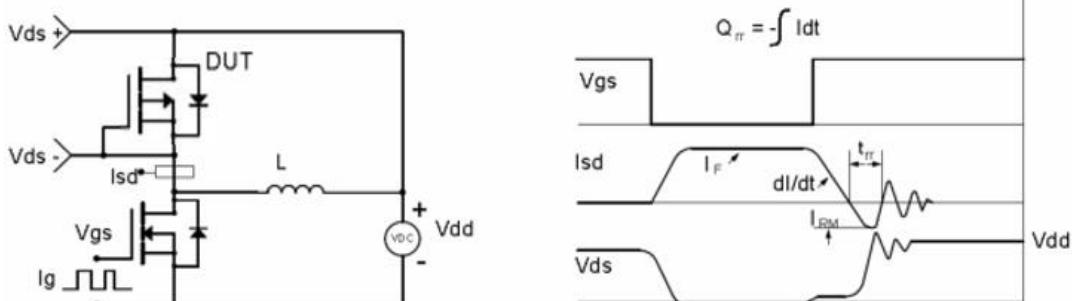
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



Typical Performance Characteristics

Fig1. Typical Output Characteristics@ $T_J = 125^\circ\text{C}$

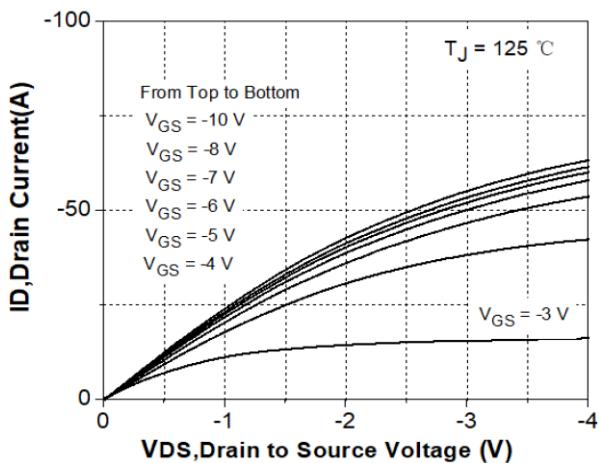


Fig2. Transconductance vs. Drain Current
@ $T_J = -25/25/75/125^\circ\text{C}$

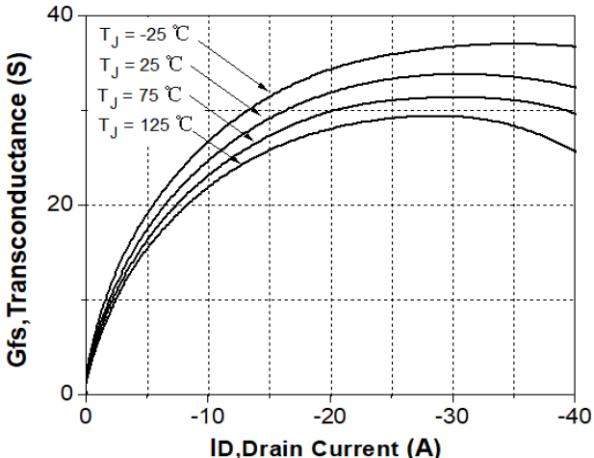


Fig3. Typical Transfer Characteristics
@ $T_J = -25/25/75/125^\circ\text{C}$

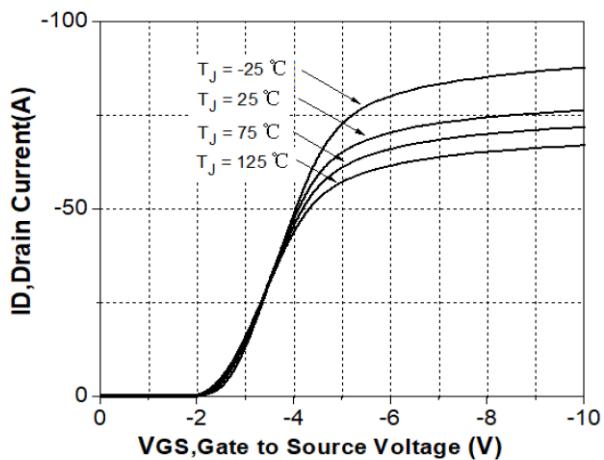


Fig4. Static Drain - Source On - State Resistance vs.
Drain Current @ $T_J = -25^\circ\text{C}$

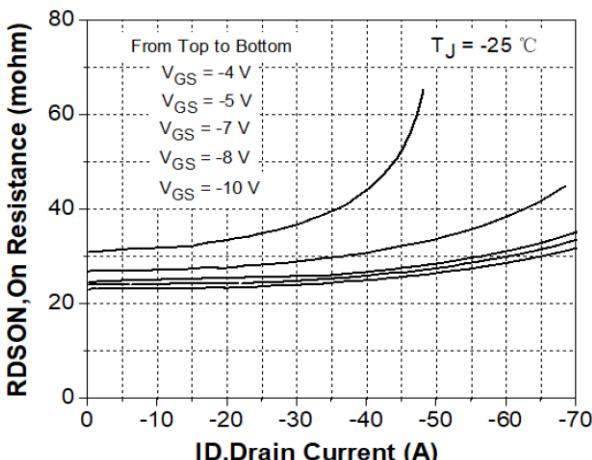


Fig5. Static Drain - Source On - State Resistance
vs. Drain Current @ $T_J = 25^\circ\text{C}$

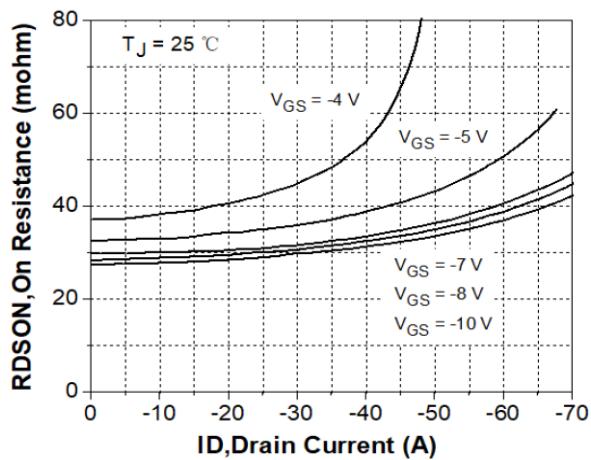


Fig6. Static Drain - Source On - State Resistance vs.
Drain Current @ $T_J = 75^\circ\text{C}$

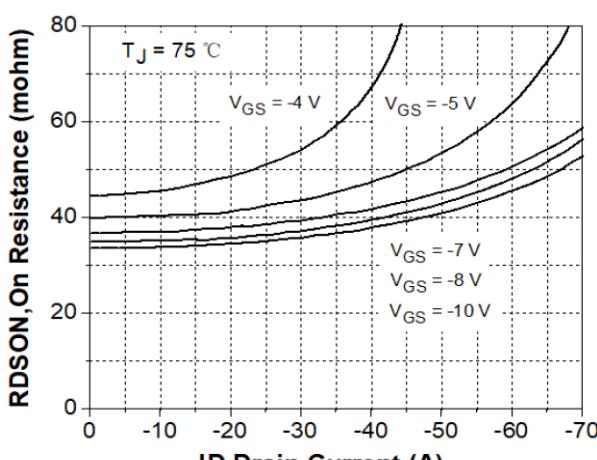


Fig7. Static Drain - Source On - State Resistance vs.
Drain Current @ $T_j = 125^\circ\text{C}$

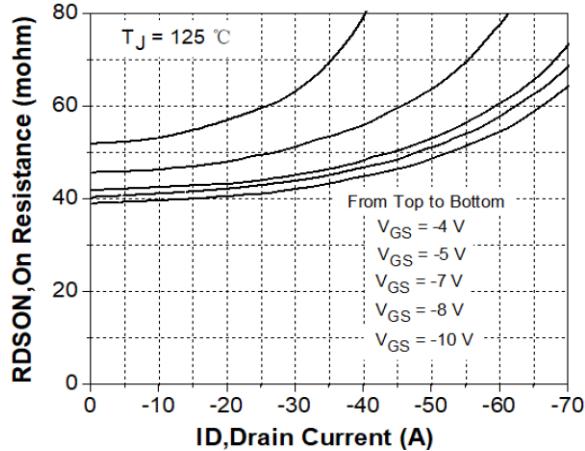


Fig9. Breakdown Voltage vs. Junction
Temperature

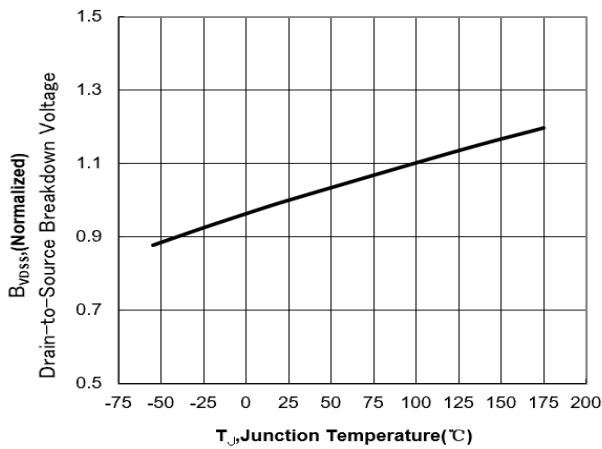


Fig11. On-Resistance Variation vs. Junction
Temperature

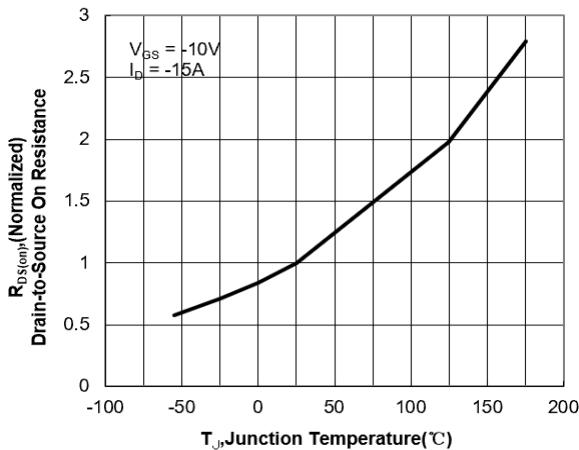


Fig8. Gate Charge Characteristics

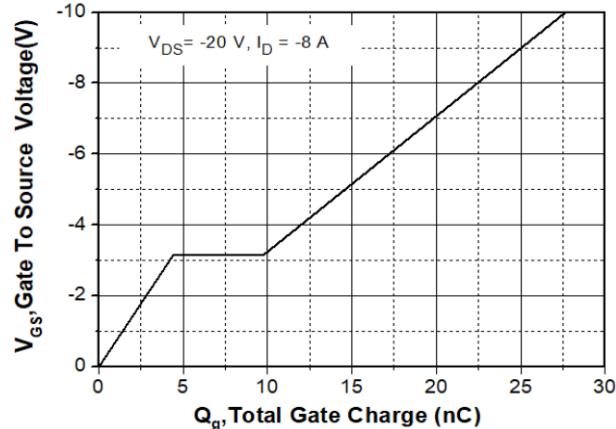


Fig10. Gate Threshold Voltage vs. Junction
Temperature

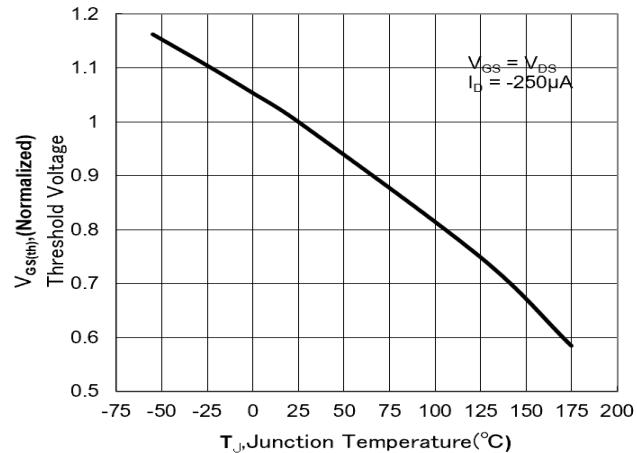


Fig12. Maximum Drain Current vs. Case
Temperature

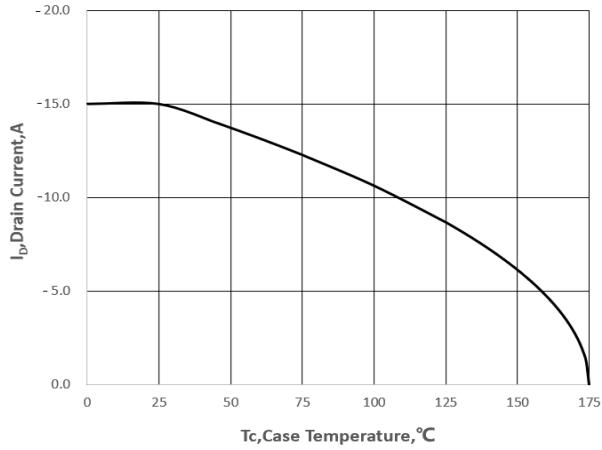


Fig13. Body Diode Forward Voltage vs. Reverse Drain Current

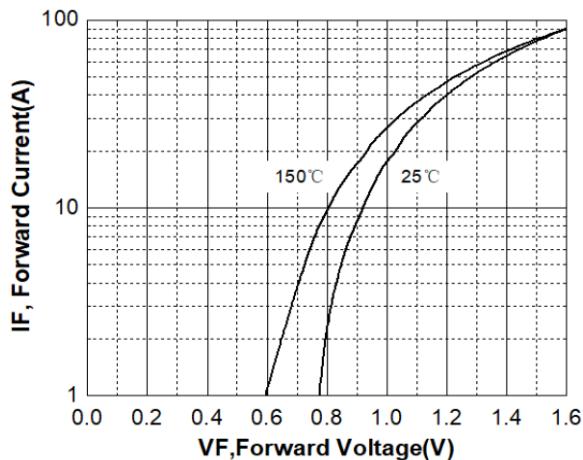


Fig14. Typical Output Characteristics@ $T_J = 25^{\circ}\text{C}$

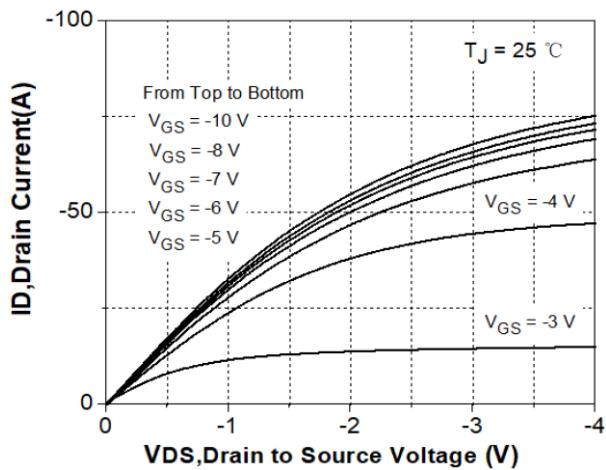


Fig15. Safe Operating Area

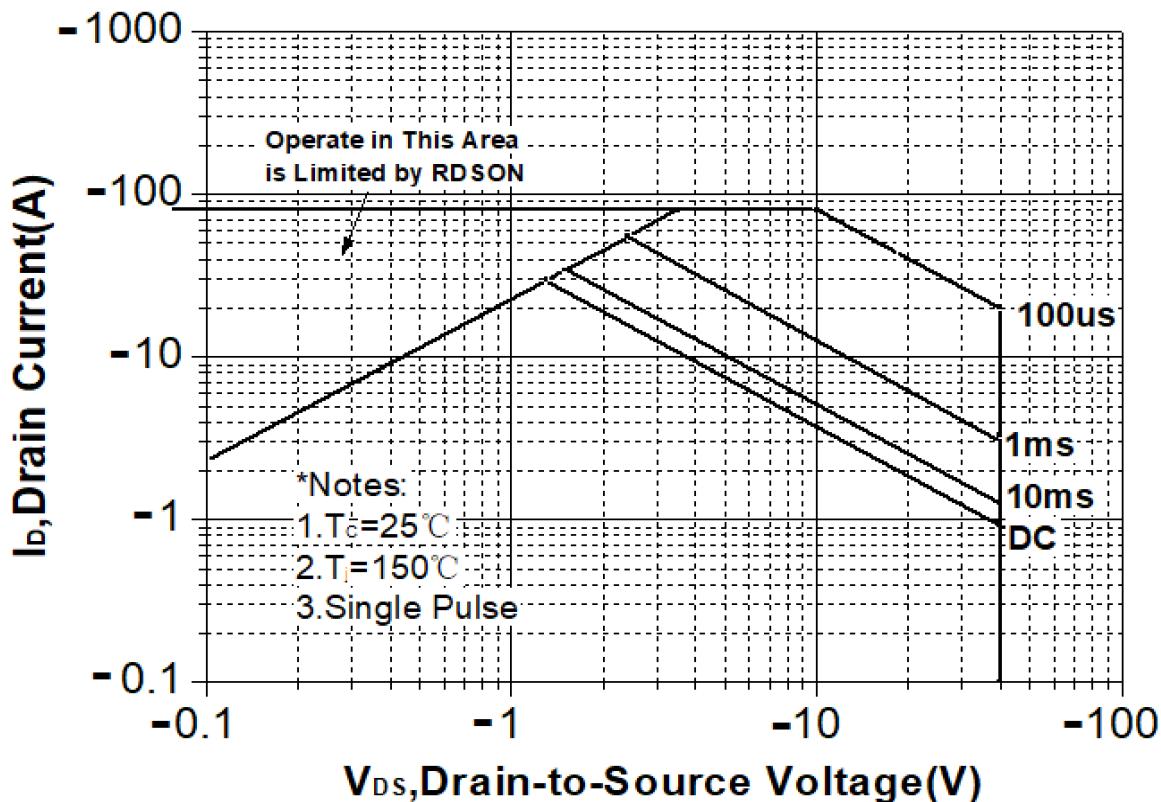
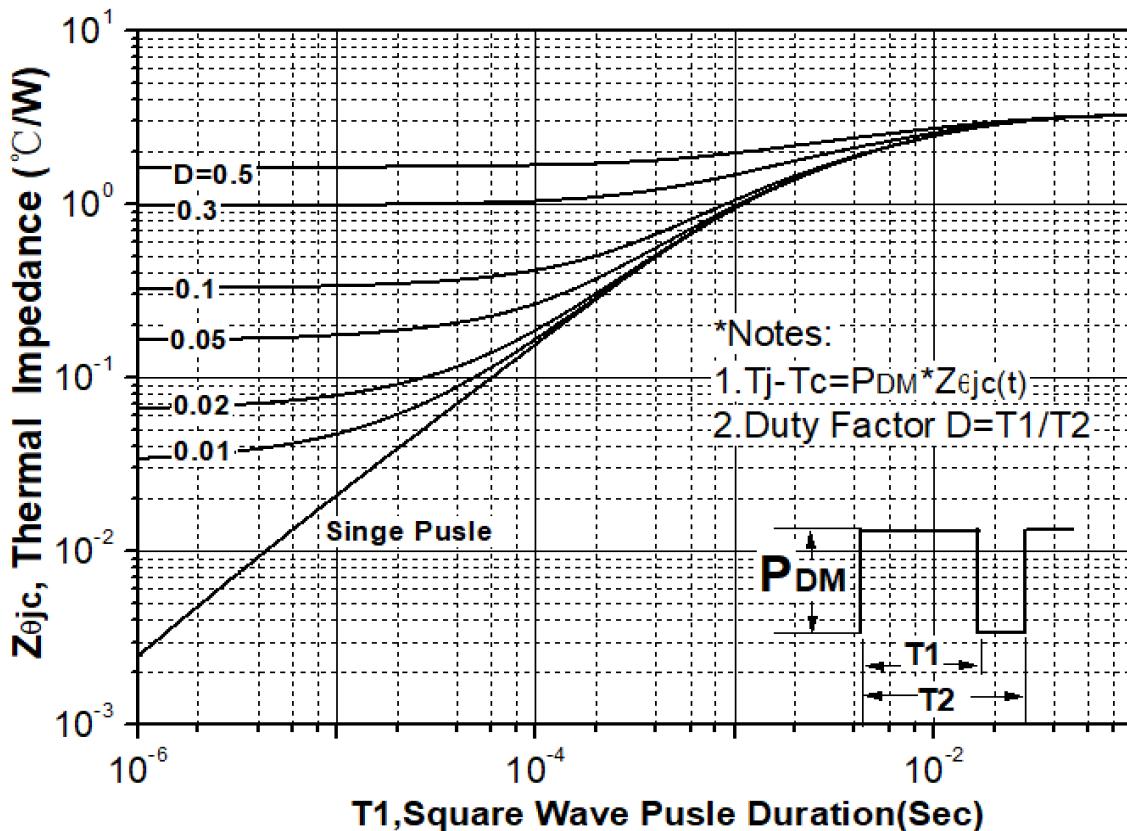
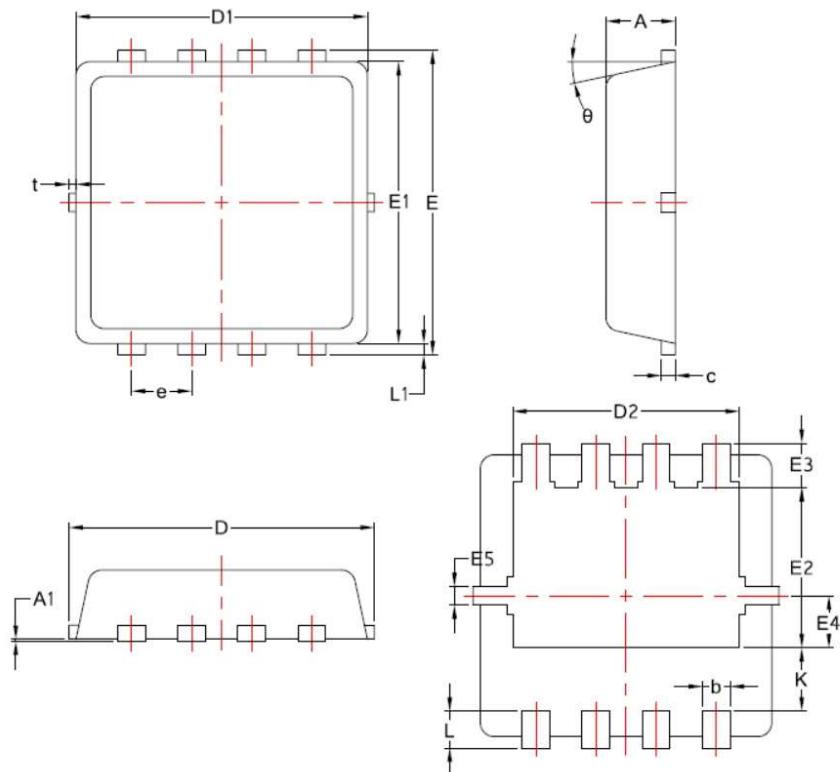


Fig16. Transient Thermal Response Curve



PDFN3X3 Package Information



SYMBOL	COMMON		
	MM		
	MIN	NOM	MAX
A	0.70	0.75	0.85
A1	/	/	0.05
b	0.20	0.30	0.40
c	0.10	0.152	0.25
D	3.15	3.30	3.45
D1	3.00	3.15	3.25
D2	2.29	2.45	2.65
E	3.15	3.30	3.45
E1	2.90	3.05	3.20
E2	1.54	1.74	1.94
E3	0.28	0.48	0.65
E4	0.37	0.57	0.77
E5	0.10	0.20	0.30
e	0.60	0.65	0.70
K	0.59	0.69	0.89
L	0.30	0.40	0.50
L1	0.06	0.125	0.20
t	0	0.075	0.13
θ	10°	12°	14°